



STD5NK52ZD, STB5NK52ZD-1 STF5NK52ZD, STP5NK52ZD

N-channel 520 V, 1.22 Ω , 4.4 A, TO-220, I²PAK, I²PAK, DPAK, TO-220FP
Zener-protected SuperMESH™ Power MOSFET

Features

| Type | V _{DSS} | R _{DS(on) max} | I _D | P _w |
|--------------|------------------|-------------------------|----------------|----------------|
| STB5NK52ZD-1 | 520 V | < 1.5 Ω | 4.4 A | 70 W |
| STD5NK52ZD-1 | 520 V | < 1.5 Ω | 4.4 A | 70 W |
| STD5NK52ZD | 520 V | < 1.5 Ω | 4.4 A | 70 W |
| STF5NK52ZD | 520 V | < 1.5 Ω | 4.4 A | 25 W |
| STP5NK52ZD | 520 V | < 1.5 Ω | 4.4 A | 70 W |

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitances
- Very good manufacturing repeatability
- Improved ESD capability

Application

- Switching applications

Description

The SuperFREDMesh™ series associates all advantages of reduced on-resistance, zener gate protection and very high dv/dt capability with a fast body-drain recovery diode. Such series complements the “FDmesh™” advanced technology.

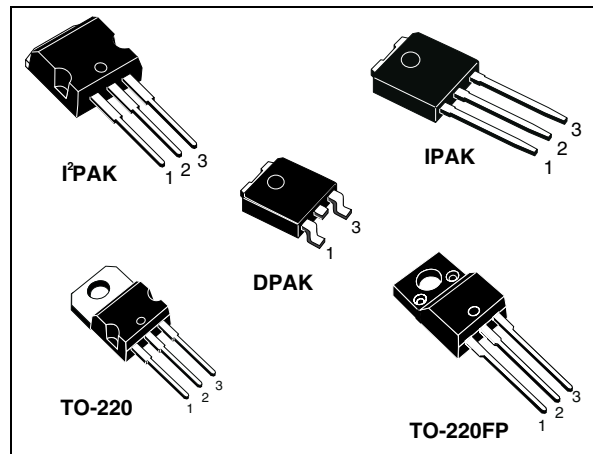


Figure 1. Internal schematic diagram

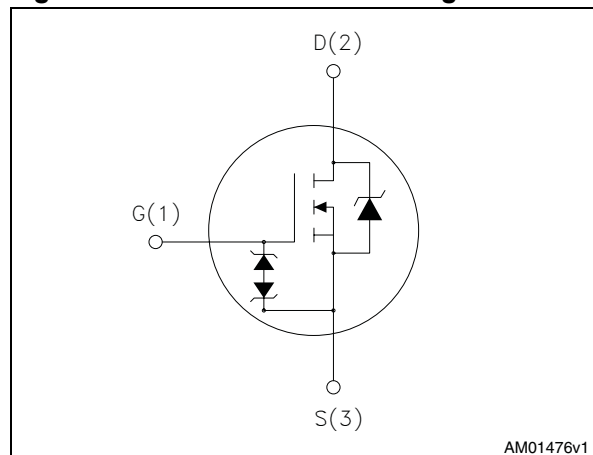


Table 1. Device summary

| Order codes | Marking | Package | Packaging |
|--------------|----------|--------------------|---------------|
| STB5NK52ZD-1 | B5NK52ZD | I ² PAK | Tube |
| STD5NK52ZD-1 | D5NK52ZD | IPAK | Tube |
| STD5NK52ZD | D5NK52ZD | DPAK | Tape and reel |
| STF5NK52ZD | F5NK52ZD | TO-220FP | Tube |
| STP5NK52ZD | P5NK52ZD | TO-220 | Tube |

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | | | Unit |
|------------------------------------|---|------------------------------|----------------------------|---------------------|------|
| | | TO-220 I ² PAK | I ² PAK DPAK | TO-220FP | |
| V _{DS} | Drain-source voltage (V _{GS} = 0) | 520 | | | V |
| V _{GS} | Gate- source voltage | ± 30 | | | V |
| I _D | Drain current (continuous) at T _C = 25 °C | 4.4 | | 4.4 ⁽¹⁾ | A |
| I _D | Drain current (continuous) at T _C = 100 °C | 2.7 | | 2.7 ⁽¹⁾ | A |
| I _{DM} ⁽²⁾ | Drain current (pulsed) | 17.6 | | 17.6 ⁽¹⁾ | A |
| P _{TOT} | Total dissipation at T _C = 25 °C | 70 | | 25 | W |
| | Derating factor | 0.56 | | 0.2 | W/°C |
| V _{ESD(G-S)} | Gate source ESD(HBM-C=100pF, R=1.5 kΩ) | 2800 | | | V |
| dv/dt ⁽³⁾ | Peak diode recovery voltage slope | 15 | | | V/ns |
| T _j T _{stg} | Operating junction temperature Storage temperature | -55 to 150 | | | °C |

- Limited only by max temperature allowed
- Pulse width limited by safe operating area
- I_{SD} ≤ 4.4 A, di/dt ≤ 200 A/μs, V_{DD} = 80% V_{(BR)DSS}

Table 3. Thermal data

| Symbol | Parameter | Value | | | Unit |
|-----------------------|--|------------------------------|----------------------------|----------|------|
| | | TO-220 I ² PAK | I ² PAK DPAK | TO-220FP | |
| R _{thj-case} | Thermal resistance junction-case max | 1.78 | | 5 | °C/W |
| R _{thj-amb} | Thermal resistance junction-ambient max | 62.5 | 100 | 62.5 | °C/W |
| T _l | Maximum lead temperature for soldering purpose | 300 | | | °C |

Table 4. Avalanche characteristics

| Symbol | Parameter | Max value | Unit |
|-----------------|--|-----------|------|
| I _{AR} | Avalanche current, repetitive or not-repetitive (pulse width limited by T _j max) | 4.4 | A |
| E _{AS} | Single pulse avalanche energy (starting T _j = 25 °C, I _D = I _{AR} , V _{DD} = 50 V) | 170 | mJ |

2 Electrical characteristics

(T_{case} = 25°C unless otherwise specified)

Table 5. On /off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------|---|---|------|------|---------|----------|
| V _{(BR)DSS} | Drain-source breakdown voltage | I _D = 1 mA, V _{GS} = 0 | 520 | | | V |
| I _{DSS} | Zero gate voltage drain current (V _{GS} = 0) | V _{DS} = Max rating V _{DS} = Max rating, T _C = 125 °C | | | 1 50 | μA μA |
| I _{GSS} | Gate-body leakage current (V _{DS} = 0) | V _{GS} = ± 20 V | | | ± 10 | μA |
| V _{GS(th)} | Gate threshold voltage | V _{DS} = V _{GS} , I _D = 50 μA | 2.5 | 3.75 | 4.5 | V |
| R _{DS(on)} | Static drain-source on resistance | V _{GS} = 10 V, I _D = 2.2 A | | 1.22 | 1.5 | Ω |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--|---|--|------|--------------------|------|----------------|
| g _{fs} | Forward transconductance | V _{DS} = 15 V, I _D = 2.2 A | | 3.1 | | S |
| C _{iss} C _{oss} C _{rss} | Input capacitance Output capacitance Reverse transfer capacitance | V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0 | | 529 71 13.4 | | pF pF pF |
| C _{OSS eq} ⁽¹⁾ | Equivalent output capacitance | V _{GS} = 0, V _{DS} = 0 to 416 V | | 11 | | pF |
| Q _g Q _{gs} Q _{gd} | Total gate charge Gate-source charge Gate-drain charge | V _{DD} = 416 V, I _D = 4.4 A, V _{GS} = 10 V (see Figure 19) | | 16.9 4.2 8.4 | | nC nC nC |

1. C_{OSS eq} is defined as a constant equivalent capacitance giving the same charging time as C_{OSS} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max | Unit |
|--------------|---------------------|--|------|------|-----|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 260 \text{ V}$, $I_D = 2.2 \text{ A}$, $R_G = 4.7 \Omega$, $V_{GS} = 10 \text{ V}$ (see Figure 18) | | 11.4 | | ns |
| t_r | Rise time | | | 13.6 | | ns |
| $t_{d(off)}$ | Turn-off-delay time | | | 23.1 | | ns |
| t_f | Fall time | | | 15 | | ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|--|------|------|------|------|
| I_{SD} | Source-drain current | | | | 4.4 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | | | 17.6 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 4.4 \text{ A}$, $V_{GS} = 0$ | | | 1.6 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 4.4 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 60 \text{ V}$ (see Figure 23) | | 97.7 | | ns |
| Q_{rr} | Reverse recovery charge | | | 300 | | nC |
| I_{RRM} | Reverse recovery current | | | 5.9 | | A |
| t_{rr} | Reverse recovery time | $I_{SD} = 4.4 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 60 \text{ V}$, $T_j = 150 \text{ }^\circ\text{C}$ (see Figure 23) | | 139 | | ns |
| Q_{rr} | Reverse recovery charge | | | 500 | | nC |
| I_{RRM} | Reverse recovery current | | | 7.2 | | A |

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300 μs , duty cycle 1.5%

Table 9. Gate-source Zener diode

| Symbol | Parameter | Test conditions | Min | Typ | Max | Unit |
|------------------|-------------------------------|--|-----|-----|-----|------|
| $BV_{GSO}^{(1)}$ | Gate-source breakdown voltage | $I_{gs} = \pm 1 \text{ mA}$ (open drain) | 30 | | | V |

1. The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220 / I²PAK

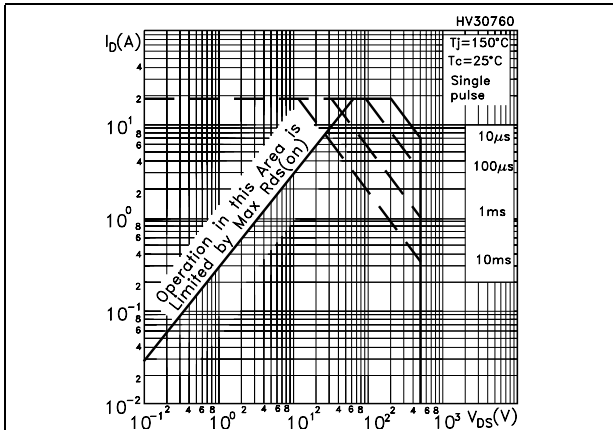


Figure 3. Thermal impedance for TO-220 / I²PAK

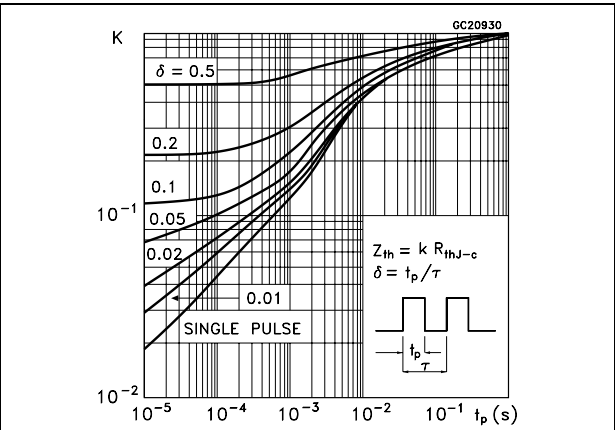


Figure 4. Safe operating area for TO-220FP

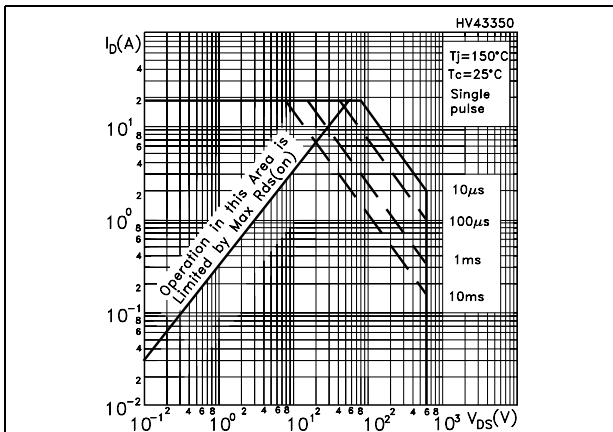


Figure 5. Thermal impedance for TO-220FP

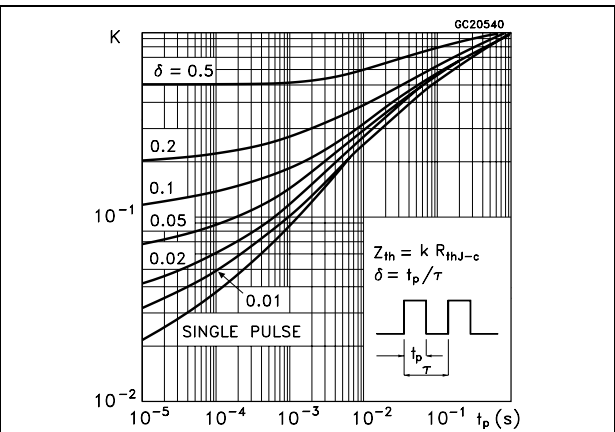


Figure 6. Safe operating area for IPAK/DPAK

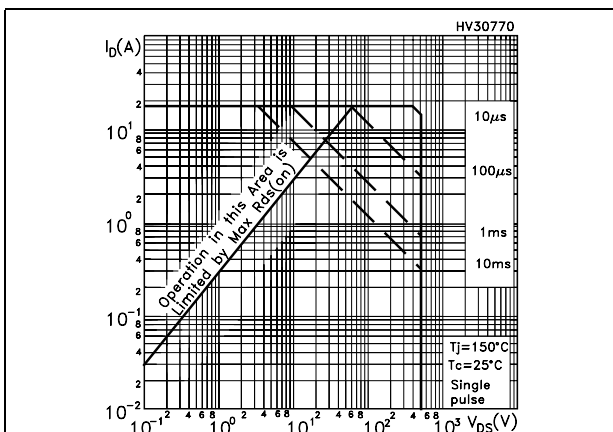


Figure 7. Thermal impedance for IPAK/DPAK

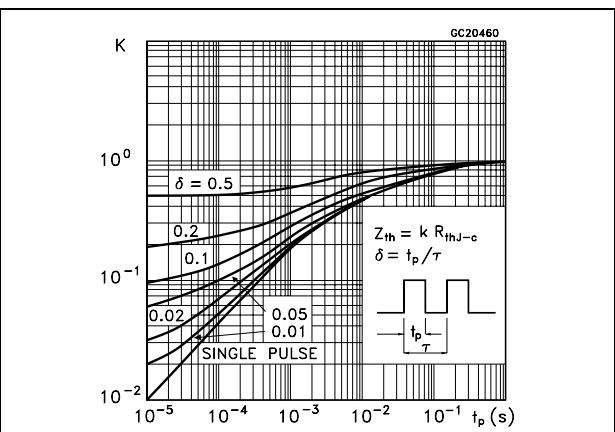


Figure 8. Output characteristics

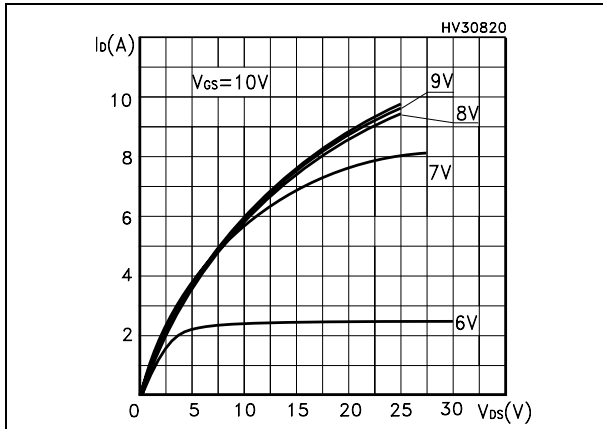


Figure 9. Transfer characteristics

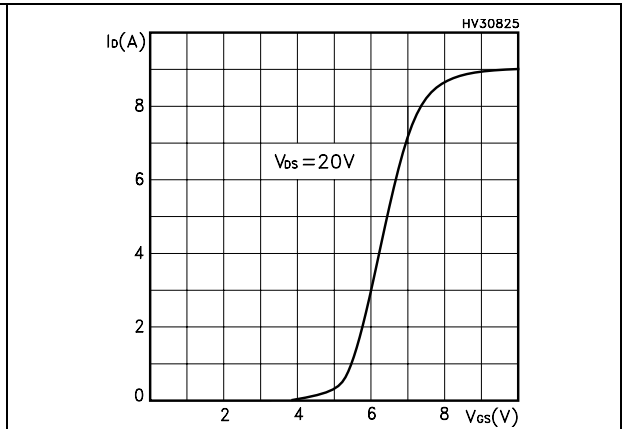


Figure 10. Normalized $B_{V_{DS}}$ vs temperature

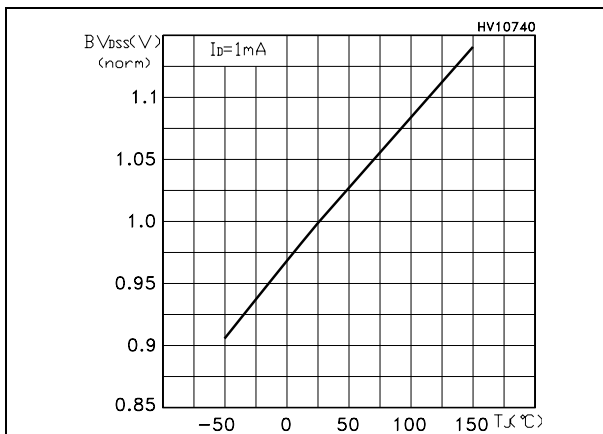


Figure 11. Static drain-source on resistance

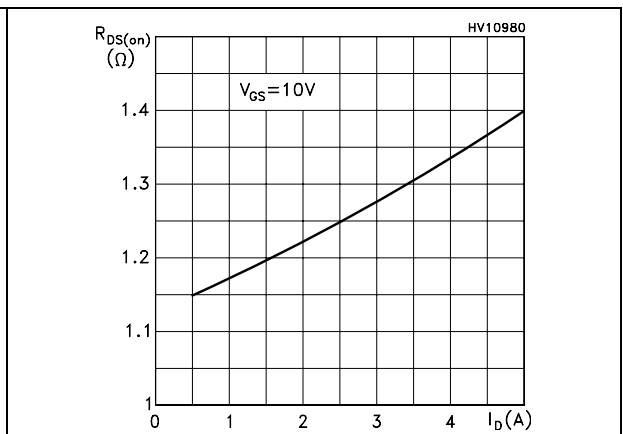


Figure 12. Gate charge vs gate-source voltage

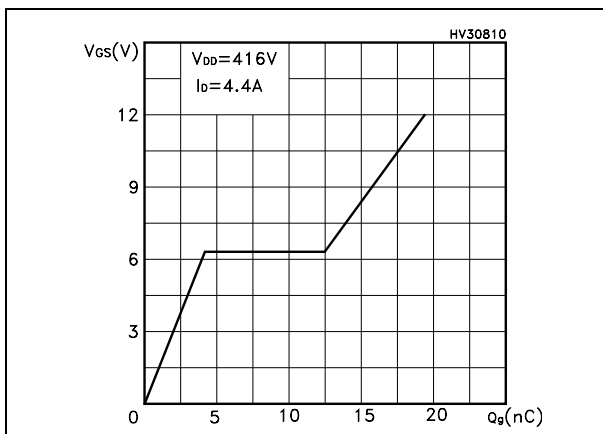


Figure 13. Capacitance variations

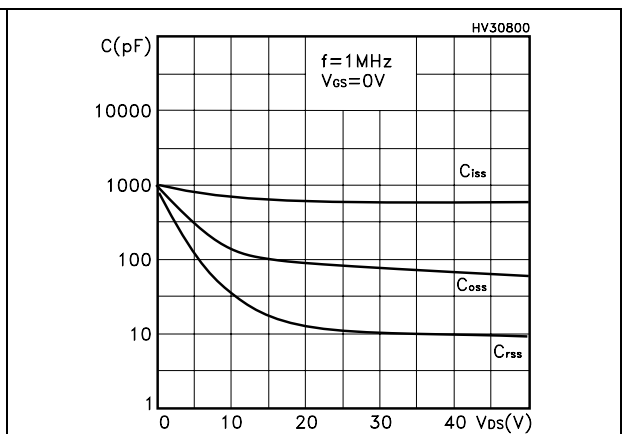


Figure 14. Normalized gate threshold voltage vs temperature

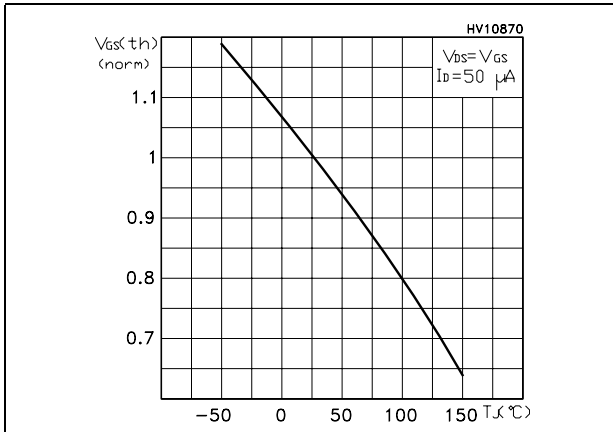


Figure 15. Normalized on resistance vs temperature

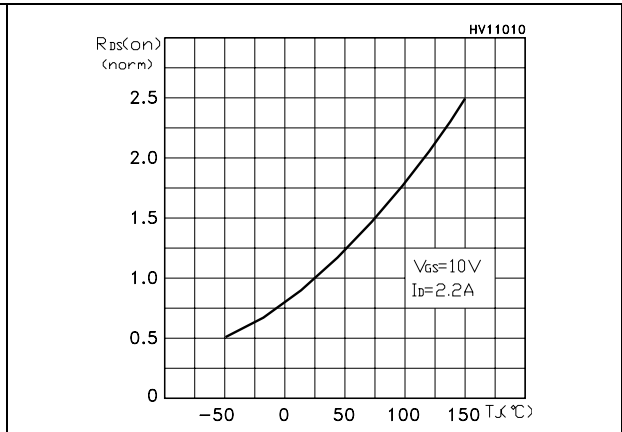


Figure 16. Source-drain diode forward characteristics

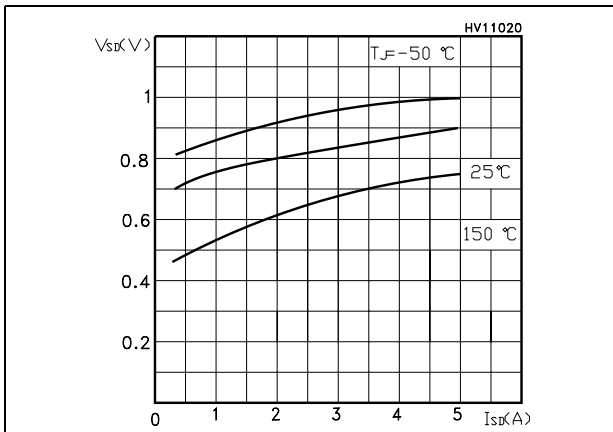
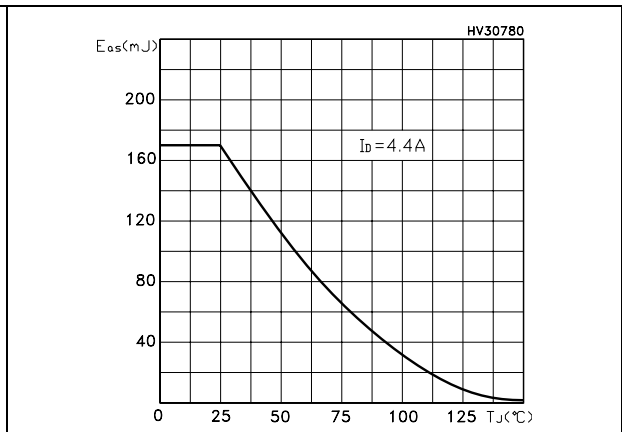


Figure 17. Maximum avalanche energy vs temperature



3 Test circuits

Figure 18. Switching times test circuit for resistive load

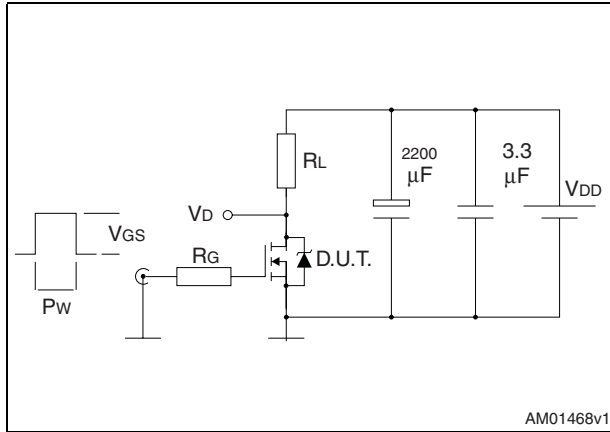


Figure 19. Gate charge test circuit

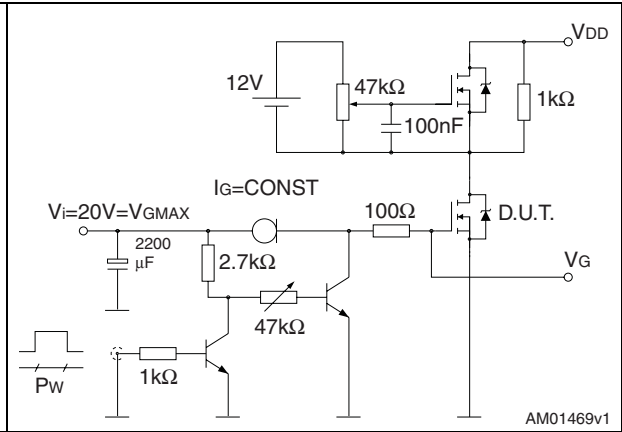


Figure 20. Test circuit for inductive load switching and diode recovery times

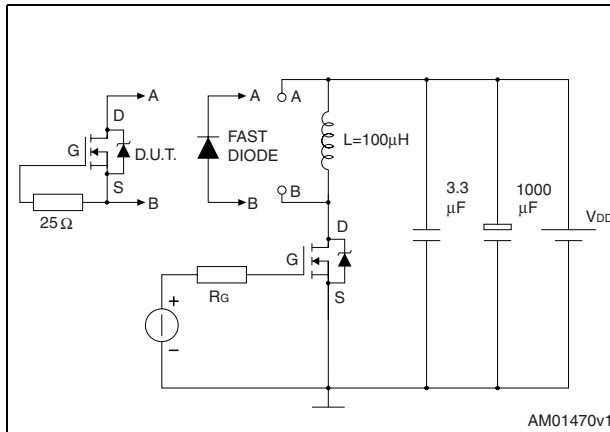


Figure 21. Unclamped Inductive load test circuit



Figure 22. Unclamped inductive waveform

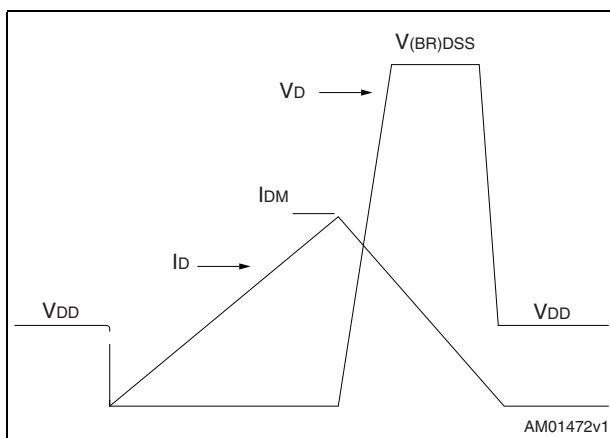
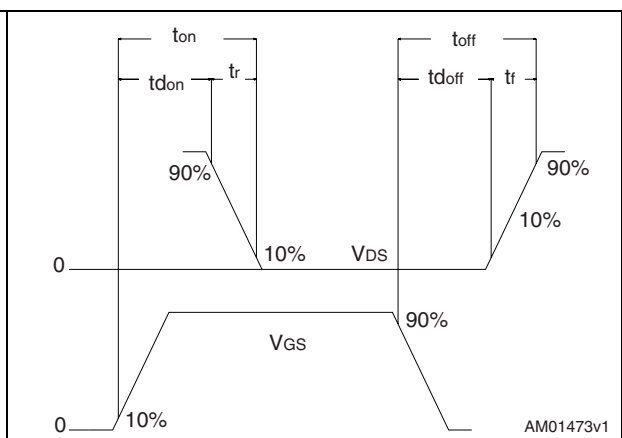


Figure 23. Switching time waveform

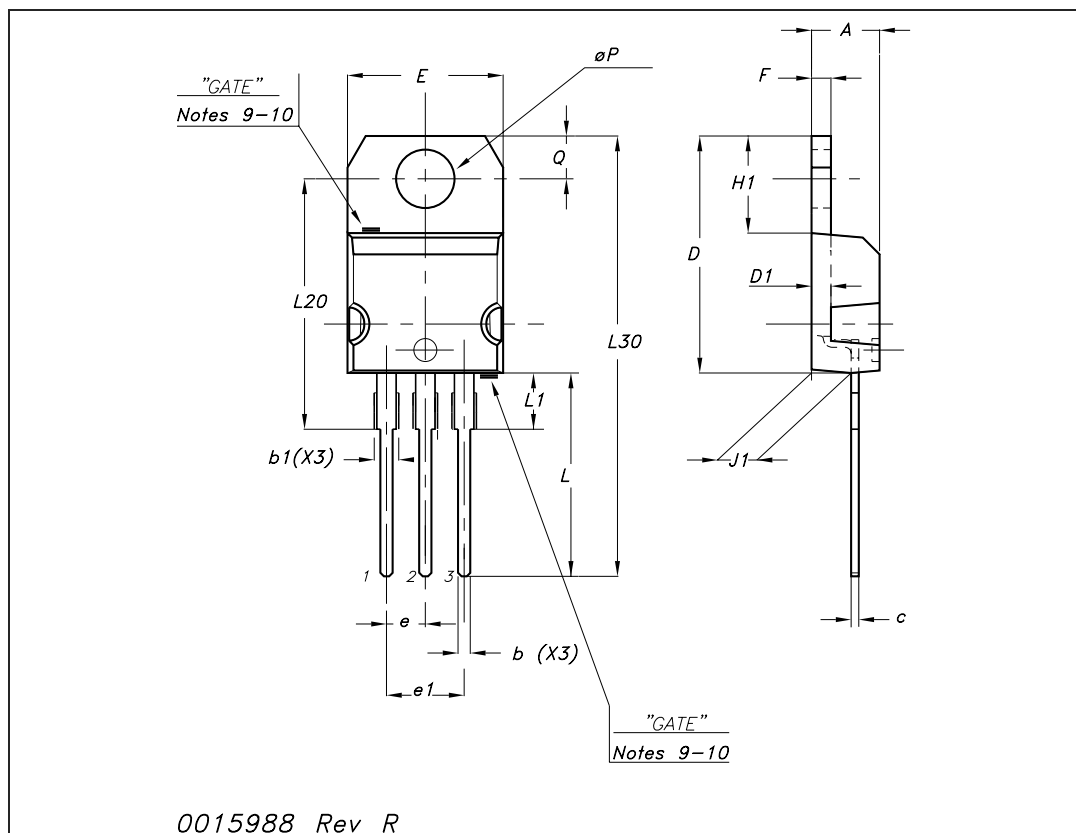


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

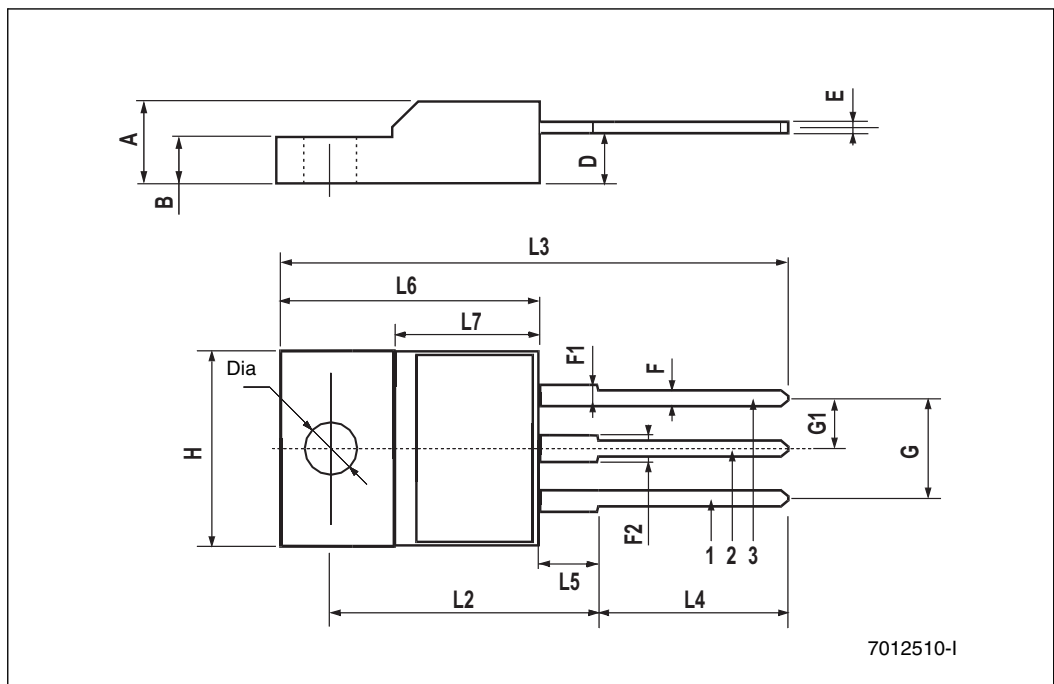
TO-220 mechanical data

| Dim | mm | | | inch | | |
|-----|-------|-------|-------|-------|-------|-------|
| | Min | Typ | Max | Min | Typ | Max |
| A | 4.40 | | 4.60 | 0.173 | | 0.181 |
| b | 0.61 | | 0.88 | 0.024 | | 0.034 |
| b1 | 1.14 | | 1.70 | 0.044 | | 0.066 |
| c | 0.48 | | 0.70 | 0.019 | | 0.027 |
| D | 15.25 | | 15.75 | 0.6 | | 0.62 |
| D1 | | 1.27 | | | 0.050 | |
| E | 10 | | 10.40 | 0.393 | | 0.409 |
| e | 2.40 | | 2.70 | 0.094 | | 0.106 |
| e1 | 4.95 | | 5.15 | 0.194 | | 0.202 |
| F | 1.23 | | 1.32 | 0.048 | | 0.051 |
| H1 | 6.20 | | 6.60 | 0.244 | | 0.256 |
| J1 | 2.40 | | 2.72 | 0.094 | | 0.107 |
| L | 13 | | 14 | 0.511 | | 0.551 |
| L1 | 3.50 | | 3.93 | 0.137 | | 0.154 |
| L20 | | 16.40 | | | 0.645 | |
| L30 | | 28.90 | | | 1.137 | |
| ∅P | 3.75 | | 3.85 | 0.147 | | 0.151 |
| Q | 2.65 | | 2.95 | 0.104 | | 0.116 |



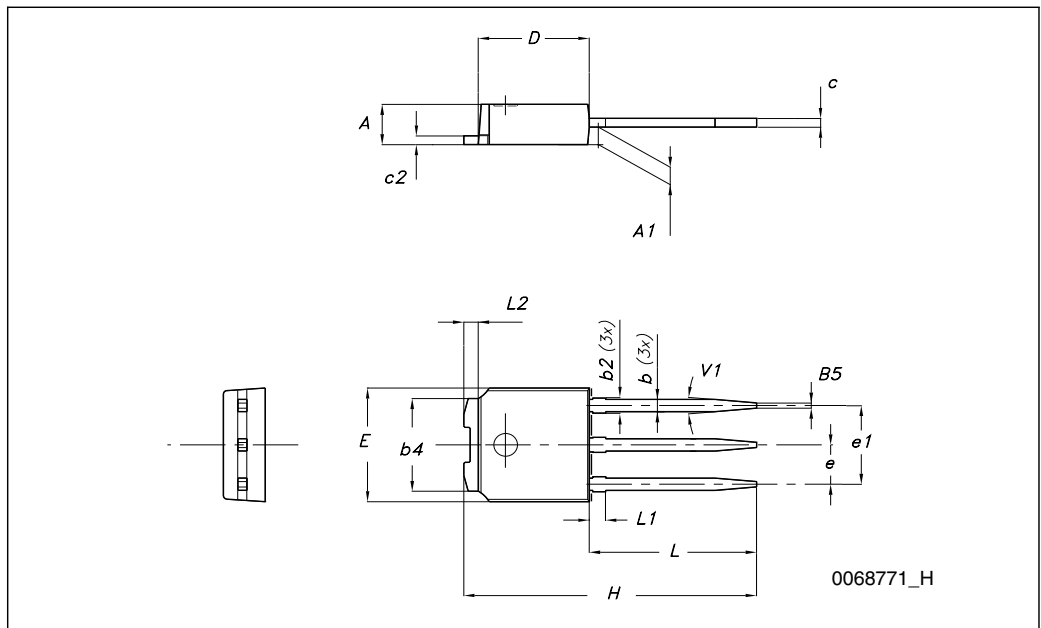
TO-220FP mechanical data

| Dim. | mm. | | | inch | | |
|------|-------|------|-------|-------|-------|-------|
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 4.40 | | 4.60 | 0.173 | | 0.181 |
| B | 2.5 | | 2.7 | 0.098 | | 0.106 |
| D | 2.5 | | 2.75 | 0.098 | | 0.108 |
| E | 0.45 | | 0.70 | 0.017 | | 0.027 |
| F | 0.75 | | 1.00 | 0.030 | | 0.039 |
| F1 | 1.15 | | 1.50 | 0.045 | | 0.067 |
| F2 | 1.15 | | 1.50 | 0.045 | | 0.067 |
| G | 4.95 | | 5.20 | 0.195 | | 0.204 |
| G1 | 2.40 | | 2.70 | 0.094 | | 0.106 |
| H | 10 | | 10.40 | 0.393 | | 0.409 |
| L2 | | 16 | | | 0.630 | |
| L3 | 28.6 | | 30.6 | 1.126 | | 1.204 |
| L4 | 9.80 | | 10.60 | 0.385 | | 0.417 |
| L5 | 2.9 | | 3.6 | 0.114 | | 0.141 |
| L6 | 15.90 | | 16.40 | 0.626 | | 0.645 |
| L7 | 9 | | 9.30 | 0.354 | | 0.366 |
| Dia | 3 | | 3.2 | 0.118 | | 0.126 |



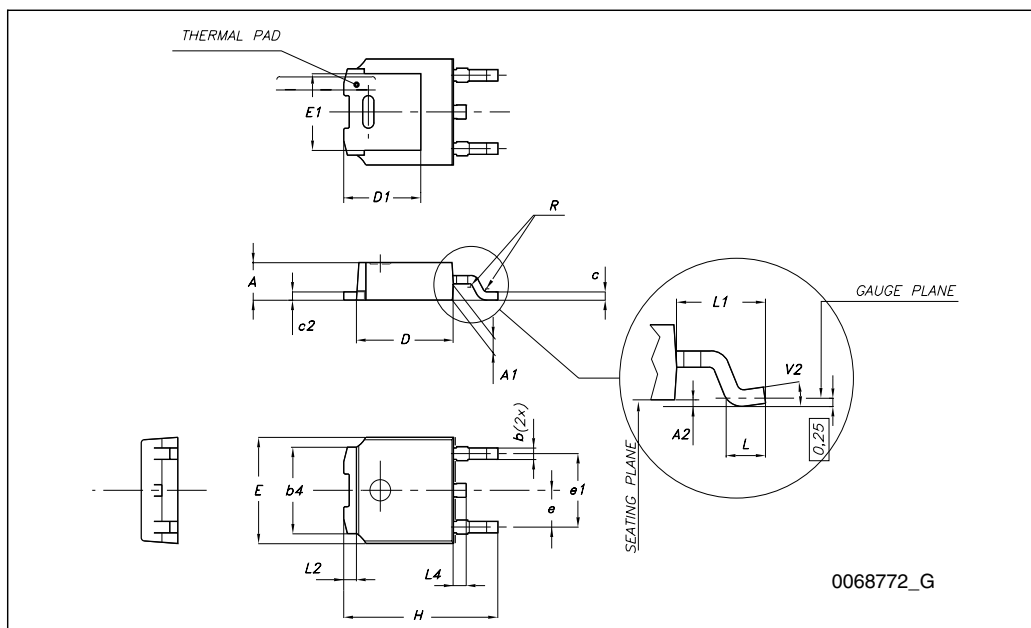
TO-251 (IPAK) mechanical data

| DIM. | mm. | | |
|------|------|-------|------|
| | min. | typ | max. |
| A | 2.20 | | 2.40 |
| A1 | 0.90 | | 1.10 |
| b | 0.64 | | 0.90 |
| b2 | | | 0.95 |
| b4 | 5.20 | | 5.40 |
| c | 0.45 | | 0.60 |
| c2 | 0.48 | | 0.60 |
| D | 6.00 | | 6.20 |
| E | 6.40 | | 6.60 |
| e | | 2.28 | |
| e1 | 4.40 | | 4.60 |
| H | | 16.10 | |
| L | 9.00 | | 9.40 |
| (L1) | 0.80 | | 1.20 |
| L2 | | 0.80 | |
| V1 | | 10° | |



TO-252 (DPAK) mechanical data

| DIM. | mm. | | |
|------|------|------|-------|
| | min. | typ | max. |
| A | 2.20 | | 2.40 |
| A1 | 0.90 | | 1.10 |
| A2 | 0.03 | | 0.23 |
| b | 0.64 | | 0.90 |
| b4 | 5.20 | | 5.40 |
| c | 0.45 | | 0.60 |
| c2 | 0.48 | | 0.60 |
| D | 6.00 | | 6.20 |
| D1 | | 5.10 | |
| E | 6.40 | | 6.60 |
| E1 | | 4.70 | |
| e | | 2.28 | |
| e1 | 4.40 | | 4.60 |
| H | 9.35 | | 10.10 |
| L | 1 | | |
| L1 | | 2.80 | |
| L2 | | 0.80 | |
| L4 | 0.60 | | 1 |
| R | | 0.20 | |
| V2 | 0° | | 8° |



5 Packaging mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT

| DIM. | mm | | inch | |
|------|------|------|-------|--------|
| | MIN. | MAX. | MIN. | MAX. |
| A | | 330 | | 12.992 |
| B | 1.5 | | 0.059 | |
| C | 12.8 | 13.2 | 0.504 | 0.520 |
| D | 20.2 | | 0.795 | |
| G | 16.4 | 18.4 | 0.645 | 0.724 |
| N | 50 | | 1.968 | |
| T | | 22.4 | | 0.881 |

| DIM. | mm | | inch | |
|------|------|------|-------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A0 | 6.8 | 7 | 0.267 | 0.275 |
| B0 | 10.4 | 10.6 | 0.409 | 0.417 |
| B1 | | 12.1 | | 0.476 |
| D | 1.5 | 1.6 | 0.059 | 0.063 |
| D1 | 1.5 | | 0.059 | |
| E | 1.65 | 1.85 | 0.065 | 0.073 |
| F | 7.4 | 7.6 | 0.291 | 0.299 |
| K0 | 2.55 | 2.75 | 0.100 | 0.108 |
| P0 | 3.9 | 4.1 | 0.153 | 0.161 |
| P1 | 7.9 | 8.1 | 0.311 | 0.319 |
| P2 | 1.9 | 2.1 | 0.075 | 0.082 |
| R | 40 | | 1.574 | |
| W | 15.7 | 16.3 | 0.618 | 0.641 |

6 Revision history

Table 10. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 16-Jun-2005 | 1 | First release |
| 06-Sep-2005 | 2 | Inserted ecopack indication |
| 03-Oct-2005 | 3 | Corrected value on Table 2 |
| 23-Mar-2006 | 4 | Complete version. New template |
| 15-Sep-2008 | 5 | Inserted new package: TO-220FP |

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